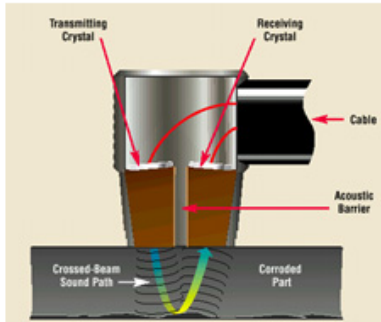


# ULTRASONIC PROBES

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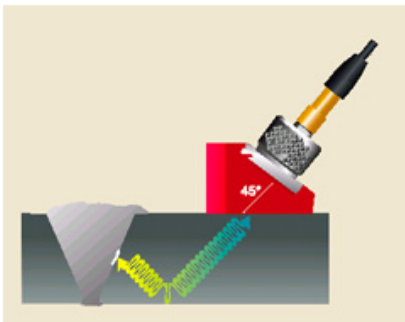
**DUAL ELEMENT PROBES**  
**ANGLE BEAM PROBES**

## DUAL ELEMENT PROBES



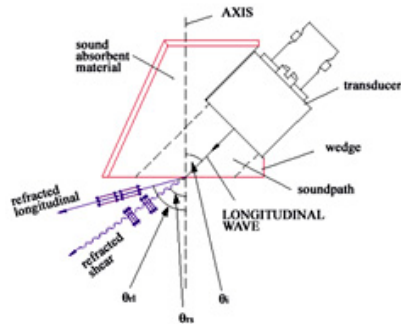
**Dual Element Probes utilize separate transmitting and receiving elements, mounted on delay lines that are usually cut at an angle.**

## ANGLE BEAM PROBES



**Angle Beam Probes are typically used to locate and/or size flaws which are oriented non-parallel to the test surface.**

## ANGLE BEAM PROBES



**Angle Beam Probes use the principles of refraction and mode conversion to produce refracted shear or longitudinal waves in the test material.**